

# SIDC14D60C6

# Fast switching diode chip in EMCON 3-Technology

## **FEATURES:**

- 600V EMCON 3 technology 70 μm chip
- soft, fast switching
- low reverse recovery charge
- · small temperature coefficient

## This chip is used for:

- power module
- discrete components



# **Applications:**

drives

Chip Type	$V_R$	I <sub>F</sub>	Die Size	Package
SIDC14D60C6	600V	50A	4.6 x 3.05 mm <sup>2</sup>	sawn on foil

### **MECHANICAL PARAMETER:**

Raster size	4.6 x 3.05				
Area total / active	14.03 / 11.12	mm <sup>2</sup>			
Anode pad size	3.9 x 2.35				
Thickness	70	μm			
Wafer size	150	mm			
Flat position	180	deg			
Max. possible chips per wafer	1013 pcs				
Passivation frontside Photoimide					
Anode metallization	3200 nm AlSiCu				
Cathode metallization	Ni Ag -system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	AI, ≤500μm				
Reject ink dot size	Ø 0.65mm; max 1.2mm				
Recommended storage environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



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# **Maximum Ratings**

Parameter	Symbol	Condition	Value	Unit
Repetitive peak reverse voltage	$V_{RRM}$		600	V
Continuous forward current limited by	1-		1)	
$T_{jmax}$	I <sub>F</sub>			Α
Maximum repetitive forward current	1		100	
limited by T <sub>jmax</sub>	<b>/</b> FRM		100	
Operating junction and storage temperature	$T_{\rm j}$ , $T_{ m stg}$		-40+175	°C

<sup>1)</sup> depending on thermal properties of assembly

# Static Electrical Characteristics (tested on chip), $T_{j}$ =25 °C, unless otherwise specified

Parameter	Symbol	Condi	Value			Unit	
raiailletei	Syllibol	Condi	itions	min. Typ. max.		max.	]
Reverse leakage current	I <sub>R</sub>	V <sub>R</sub> = 600 V	<i>T<sub>j</sub></i> =25° <i>C</i>			27	μΑ
Cathode-Anode breakdown Voltage	V <sub>Br</sub>	I <sub>R</sub> = 0.25mA	$T_j=25^{\circ}C$	600			V
Forward voltage drop	$V_{F}$	I <sub>F</sub> = 50 A	<i>T<sub>j</sub>=25°C</i>	1.2	1.6	1.9	V

# Dynamic Electrical Characteristics (verified by design/characterization), inductive load

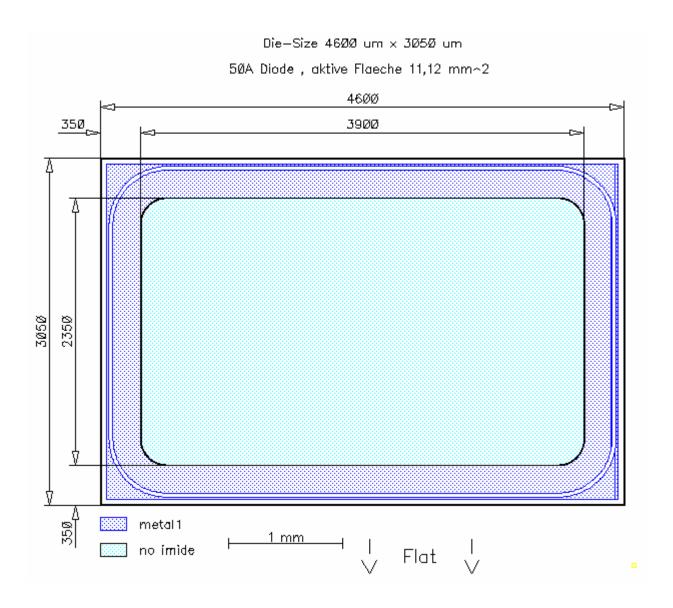
Parameter	Symbol	Conditions		Value 2)			Unit
raiailletei	Syllibol	Condi	min.	Тур.	max.		
Peak reverse recovery current	I <sub>RM</sub>	$I_F=50A$ $di/dt=2800A/\mu s$ $V_R=300V$ $V_{GE}=-15V$	$T_j = 25  ^{\circ}C$ $T_j = 125  ^{\circ}C$ $T_j = 150  ^{\circ}C$		69.0 76.0 80.0		А
Recovered charge	Q <sub>r</sub>	$I_F=50A$ $di/dt=2800A/\mu s$ $V_R=300V$ $V_{GE}=-15V$	$T_j = 25 \text{ °C}$ $T_j = 125 \text{ °C}$ $T_j = 150 \text{ °C}$		1.90 3.40 3.95		μC
Reverse recovery energy	E <sub>rec</sub>	$I_F=50A$ $di/dt=2800A/\mu s$ $V_R=300V$ $V_{GE}=-15V$	$T_j = 25 \text{ °C}$ $T_j = 125 \text{ °C}$ $T_j = 150 \text{ °C}$		0.60 0.95 1.10		mJ

<sup>&</sup>lt;sup>2)</sup> values also influenced by parasitic L- and C- in measurement and package.





### **CHIP DRAWING:**





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# This chip data sheet refers to the device data sheet Description: AQL 0,65 for visual inspection according to failure catalog Electrostatic Discharge Sensitive Device according to MIL-STD 883 Test-Normen Villach/Prüffeld

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